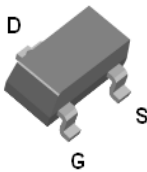


# PM606BA

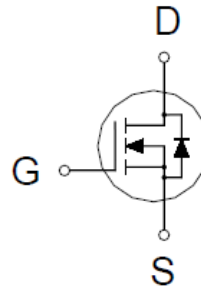
## N-Channel Enhancement Mode MOSFET

### PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	$I_D$
30V	20m $\Omega$ @ $V_{GS} = 10V$	5A



SOT-23(S)



### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25\text{ }^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		$V_{DS}$	30	V
Gate-Source Voltage		$V_{GS}$	$\pm 20$	
Continuous Drain Current	$T_A = 25\text{ }^\circ\text{C}$	$I_D$	5	A
	$T_A = 70\text{ }^\circ\text{C}$		3.7	
Pulsed Drain Current <sup>1</sup>		$I_{DM}$	15	
Power Dissipation	$T_A = 25\text{ }^\circ\text{C}$	$P_D$	0.8	W
	$T_A = 70\text{ }^\circ\text{C}$		0.5	
Operating Junction & Storage Temperature Range		$T_J, T_{STG}$	-55 to 150	$^\circ\text{C}$

### THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient <sup>2</sup>	$R_{\theta JA}$		146	$^\circ\text{C} / \text{W}$

<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25\text{ }^\circ\text{C}$ .

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## N-Channel Enhancement Mode MOSFET

### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25 °C, Unless Otherwise Noted)

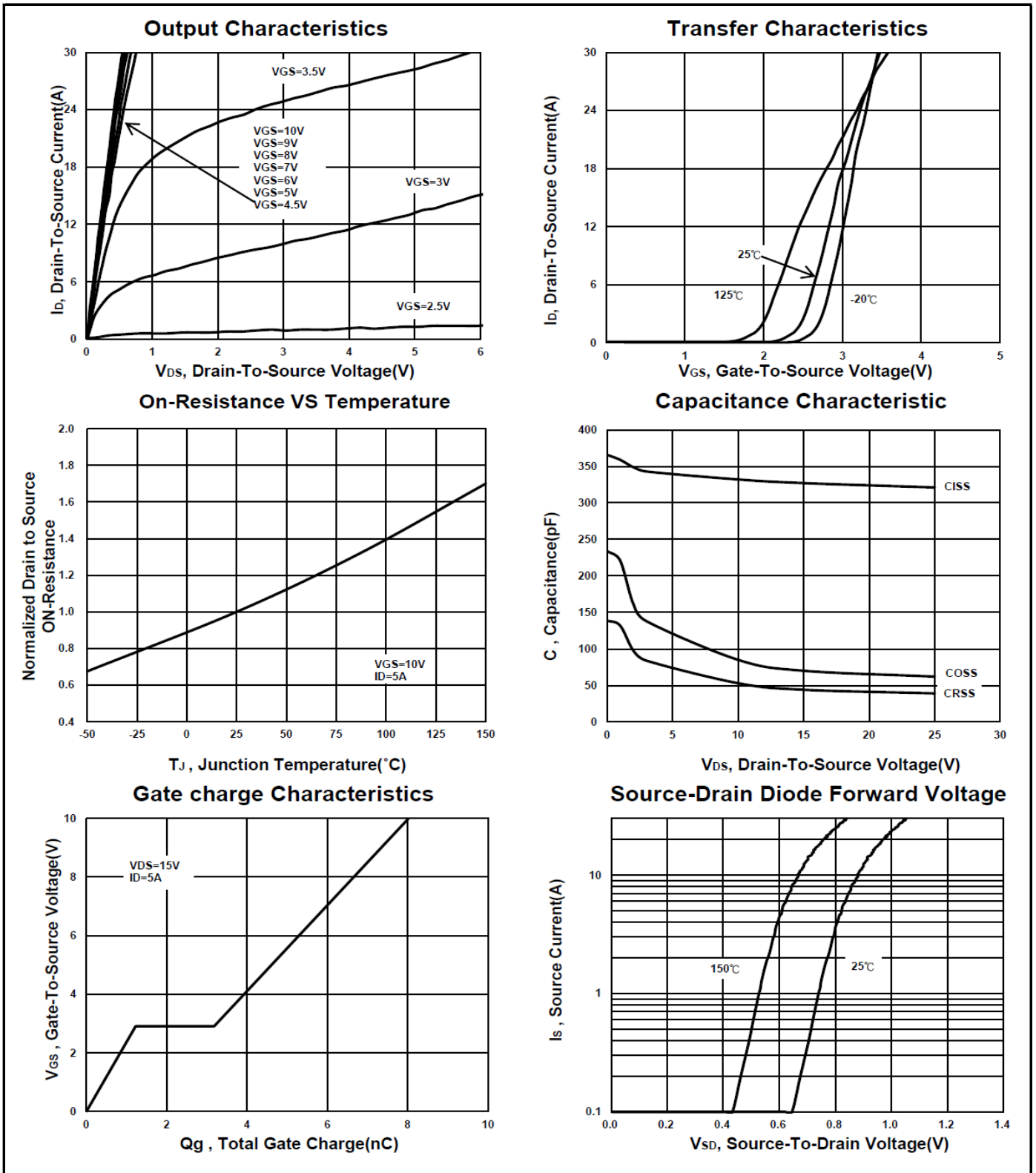
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNITS
			MIN	TYP	MAX	
<b>STATIC</b>						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	30			V
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	1.3	1.75	2.3	
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±20V			±100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V			1	μA
		V <sub>DS</sub> = 20V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 55 °C			10	
Drain-Source On-State Resistance <sup>1</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 5A		23	31	mΩ
		V <sub>GS</sub> = 10V, I <sub>D</sub> = 5A		17	20	
Forward Transconductance <sup>1</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 5V, I <sub>D</sub> = 5A		26		S
<b>DYNAMIC</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 15V, f = 1MHz		329		pF
Output Capacitance	C <sub>oss</sub>			70		
Reverse Transfer Capacitance	C <sub>riss</sub>			45		
Total Gate Charge <sup>2</sup>	Q <sub>g</sub>	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 10V, I <sub>D</sub> = 5A		7.8		nC
Gate-Source Charge <sup>2</sup>	Q <sub>gs</sub>			1.2		
Gate-Drain Charge <sup>2</sup>	Q <sub>gd</sub>			2.3		
Turn-On Delay Time <sup>2</sup>	t <sub>d(on)</sub>	V <sub>DS</sub> = 15V I <sub>D</sub> ≅ 5A, V <sub>GS</sub> = 10V, R <sub>GEN</sub> = 6Ω		17		nS
Rise Time <sup>2</sup>	t <sub>r</sub>			17		
Turn-Off Delay Time <sup>2</sup>	t <sub>d(off)</sub>			37		
Fall Time <sup>2</sup>	t <sub>f</sub>			18		
<b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTIC ( T<sub>J</sub> = 25 °C )</b>						
Continuous Current	I <sub>S</sub>				0.7	A
Forward Voltage <sup>1</sup>	V <sub>SD</sub>	I <sub>F</sub> = 5A, V <sub>GS</sub> = 0V			1.1	V
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 5A, dI <sub>F</sub> /dt = 100 A/μs		10		nS
Reverse Recovery Charge	Q <sub>rr</sub>				2.6	

<sup>1</sup>Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.

<sup>2</sup>Independent of operating temperature.

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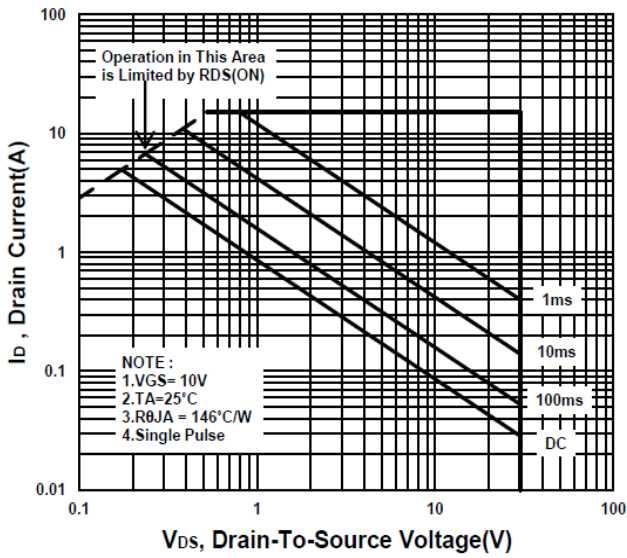
## N-Channel Enhancement Mode MOSFET



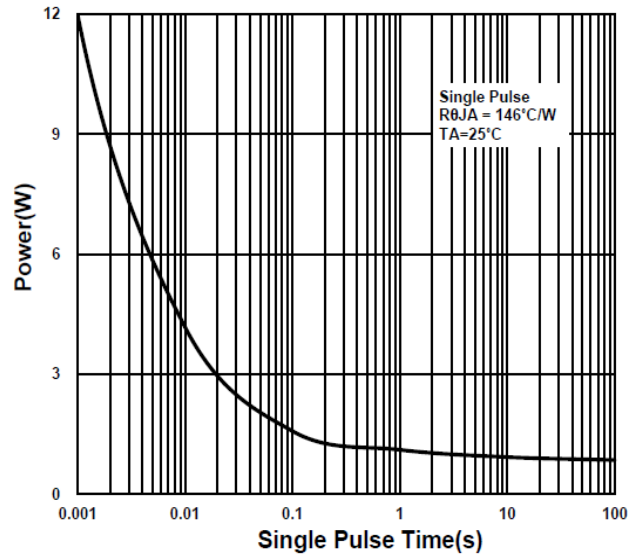
# PM606BA

## N-Channel Enhancement Mode MOSFET

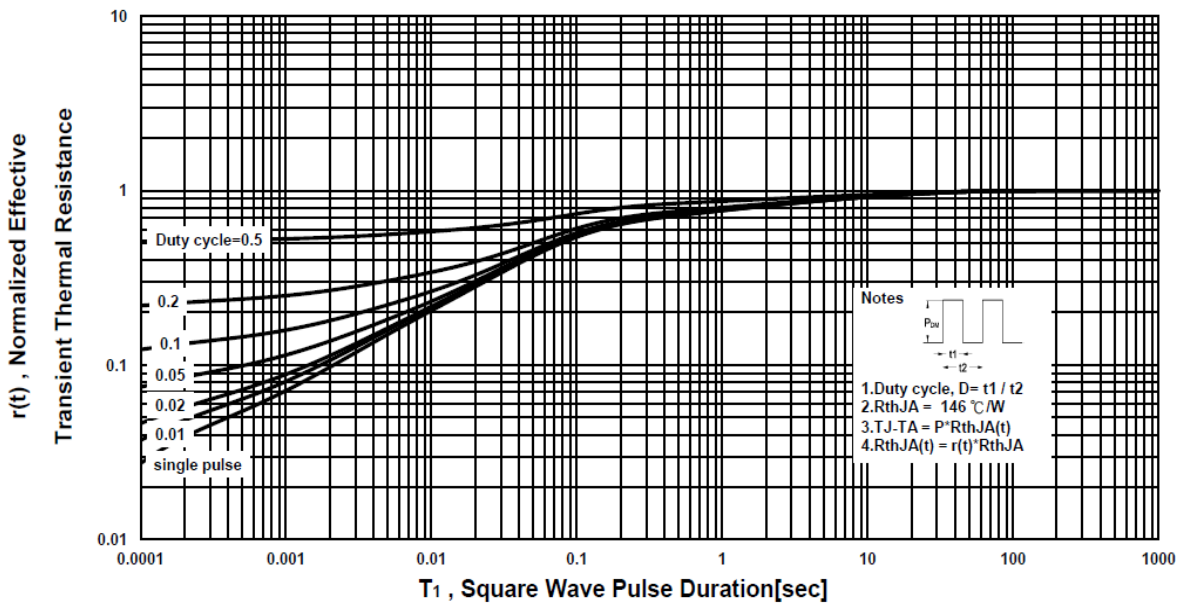
**Safe Operating Area**



**Single Pulse Maximum Power Dissipation**



**Transient Thermal Response Curve**



**PM606BA**  
**N-Channel Enhancement Mode MOSFET**

**Package Dimension**

**SOT-23 (S) MECHANICAL DATA**

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	0.9		1	H	0.08		0.2
B	2.25		2.85	I	0.15		0.6
C	1.2		1.4				
D	2.8		3.04				
E	0.89		1.2				
F	0		0.1				
G	0.3		0.5				

